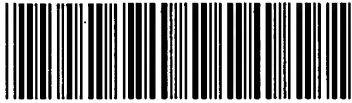


**Search Notes**

Application/Control No.

10/760,060

Examiner

Nhan T. Le

Applicant(s)/Patent under  
Reexamination

JIN ET AL.

Art Unit

2618

**SEARCHED**

Class	Subclass	Date	Examiner
Updated search		02/21/07	N. Le

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East search	02/21/07	N. Le